

STD17NF03L STD17NF03L-1

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STD17NF03L-1	30V	<0.05Ω	17A
STD17NF03L	30V	<0.05Ω	17A

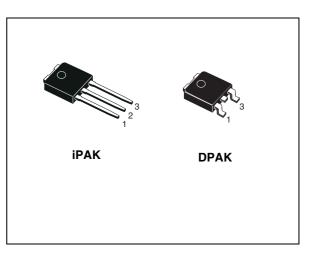
- Exceptional dv/dt capability
- Low gate charge at 100°C
- Application oriented characterization
- 100% avalanche tested

Description

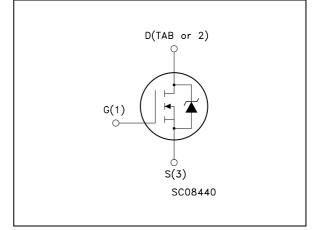
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Applications

Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STD17NF03L-1	D17NF03L@	IPAK	Tube
STD17NF03LT4	D17NF03L@	DPAK	Tape & reel

Contents

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Electrical ratings

Table 1.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{DGR}	Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)	30	V
V _{GS}	Gate- source voltage	± 16	V
۱ _D	Drain current (continuous) at $T_C = 25^{\circ}C$	17	А
۱ _D	Drain current (continuous) at $T_C = 100^{\circ}C$	12	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	68	А
P _{tot}	Total dissipation at $T_C = 25^{\circ}C$	30	W
	Derating Factor	0.2	W/°C
dv/dt ⁽²⁾	Peak diode recovery avalanche energy	7	V/ns
E _{AS} ⁽³⁾	Single pulse avalanche energy	200	mJ
T _{stg}	Storage temperature		
Тj	Max. operating junction temperature	55 to 175	°C

1. Pulse width limited by safe operating area.

2. $I_{SD} \leq 7A$, di/dt $\leq 300A/\mu s$, $V_{DD} = V_{(BR)DSS}$, $T_j \leq T_{JMAX}$

3. Starting $T_j = 25 \text{ °C}$, $I_D = 8.5A$, $V_{DD} = 15V$

Rthj-case	Thermal resistance junction-case max	5.0	°C/W
Rthj-amb	Thermal resistance junction-to ambient max	100	°C/W
TJ	Maximum lead temperature for soldering purpose	275	°C

2 Electrical characteristics

(T_{CASE} =25°C unless otherwise specified)

	0.40.00					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250µA, V _{GS} =0	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating V_{DS} = Max rating, T_{C} = 125°C			1 10	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 16V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1	1.5	2.2	V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 8.5A$ $V_{GS} = 5V, I_D = 8.5A$		0.038 0.045	0.05 0.06	Ω Ω

Table 3. On/off states

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} > I _{D(on)} x R _{DS(on)max} , I _D =8.5A		12		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25V, f = 1MHz, V _{GS} = 0		320 155 28		pF pF pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 15V, I_D = 8.5A$ $R_G = 4.7\Omega V_{GS} = 5V$ (see <i>Figure 13</i>)		11 100 25 22		ns ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 3024V, I_D = 17A,$ $V_{GS} = 5V, R_G = 4.7\Omega$ (see <i>Figure 14</i>)		4.8 2.25 1.7	6.5	nC nC nC

1. Pulsed: Pulse duration = $300 \ \mu s$, duty cycle 1.5%.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				22 88	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 17A, V _{GS} = 0			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 17A$, di/dt = 100A/µs, $V_{DD} = 15V$, $T_j = 150^{\circ}C$ (see <i>Figure 15</i>)		28 18 1.3		ns nC A

Table 5.Source drain diode

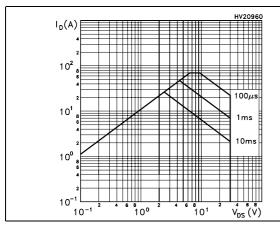
1. Pulse width limited by safe operating area.

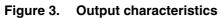
2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

Figure 1. Safe operating area





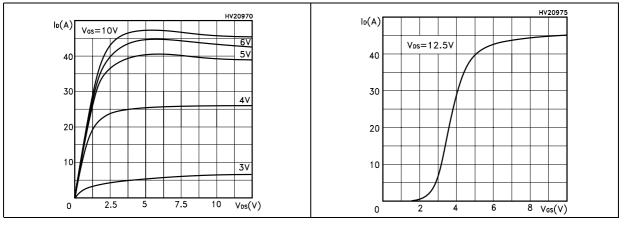
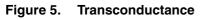
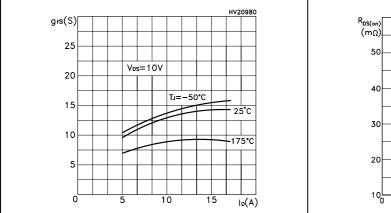
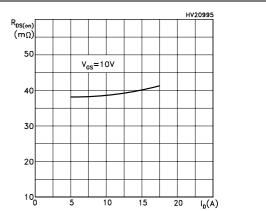


Figure 2.





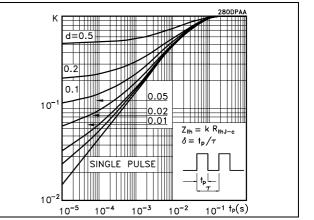




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Thermal impedance

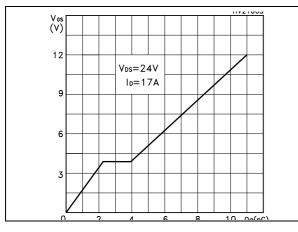
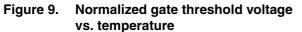


Figure 7. Gate charge vs. gate-source voltage Figure 8. Capacitance variations



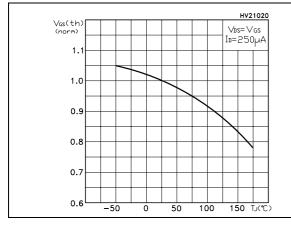


Figure 11. Source-drain diode forward characteristics

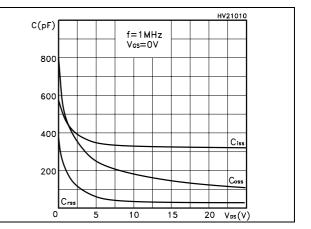


Figure 10. Normalized on resistance vs. temperature

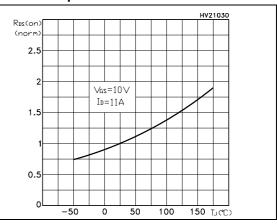
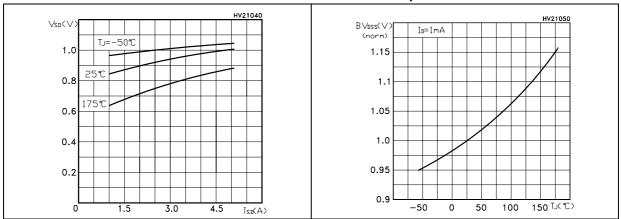


Figure 12. Normalized breakdown voltage vs. temperature



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3 Test circuit

Figure 13. Switching times test circuit for resistive load

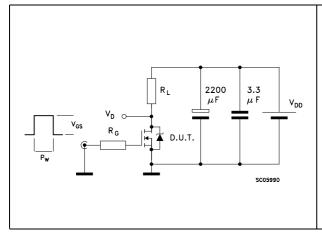
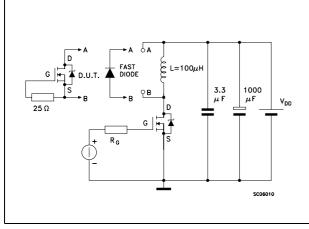
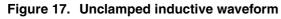


Figure 15. Test circuit for inductive load switching and diode recovery times





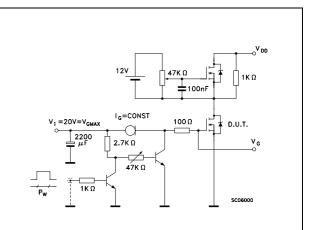
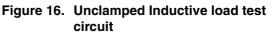


Figure 14. Gate charge test circuit



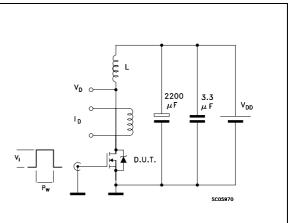
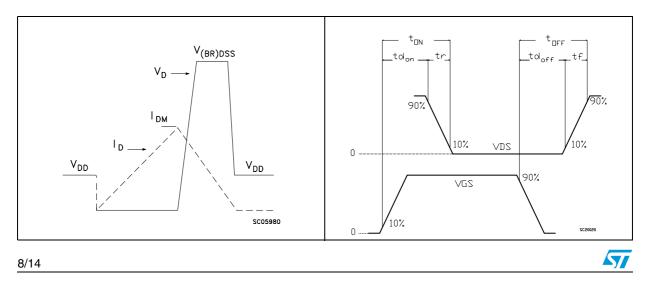


Figure 18. Switching time waveform



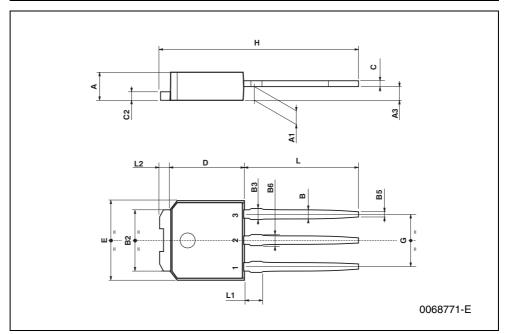
4 Package mechanical data

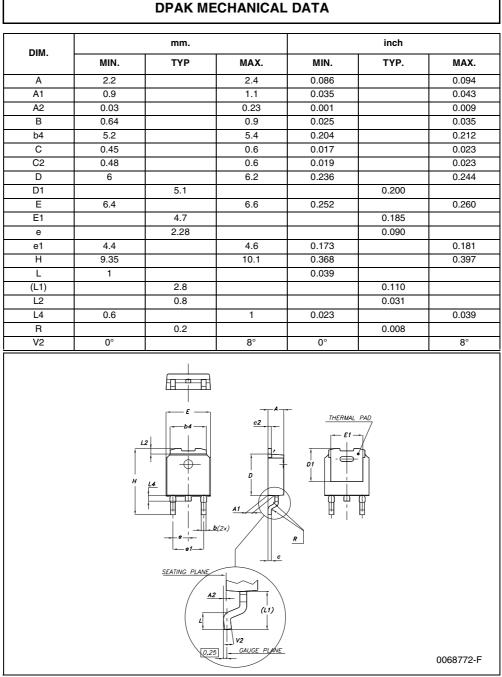
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM.		mm			inch	
DIM.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
B3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
Е	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039

TO-251 (IPAK) MECHANICAL DATA



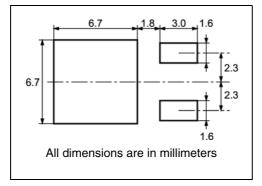


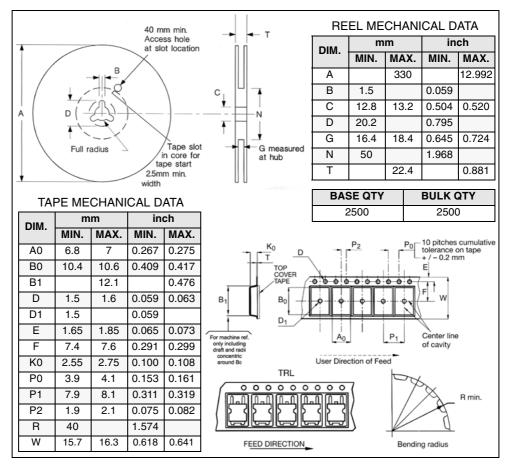
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5 Packing mechanical data

DPAK FOOTPRINT





TAPE AND REEL SHIPMENT

6 Revision history

Date	Revision	Changes
19-Oct-2004	1	First release
20-Nov-2004	2	Modified value in title
03-Jul-2006	3	New template, no content change
19-Feb-2007	4	Typo mistake on page 1



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